

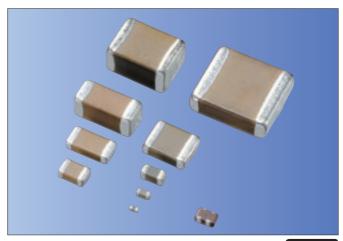




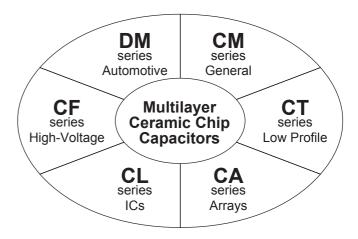
Kyocera's series of Multilayer Ceramic Chip Capacitors are designed to meet a wide variety of needs. We offer a complete range of products for both general and specialized applications, including CM series for generalpurpose, CT series for low profile, CA series for arrays, CL series for ICs, CF series for high-voltage, and DM series for automotive.

#### **Features**

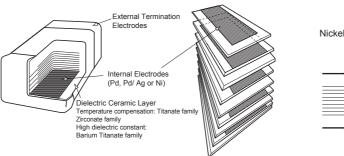
- We have factories worldwide in order to supply our global customer bases quickly and efficiently and to maintain our reputation as one of the highest-volume producers in the industry.
- All our products are highly reliable due to their monolithic structure of high-purity and superfine uniform ceramics and their integral internal electrodes.
- By combining superior manufacturing technology and materials with high dielectric constants, we produce extremely compact components with exceptional specifications.
- Our stringent quality control in every phase of production from material procurement to shipping ensures consistent manufacturing and super quality.
- Kyocera components are available in a wide choice of dimensions, temperature characteristics, rated voltages, and terminations to meet specific configurational requirements.



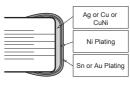
**RoHS Compliant** 



### **Structure**



#### Nickel Barrier Termination Products



### **Tape and Reel**



### **Bulk Case**



Please contact your local AVX, Kyocera sales office or distributor for specifications not covered in this catalog.

Our products are continually being improved. As a result, the capacitance range of each series is subject to change without notice. Please contact an sales representative to confirm compatibility with your application.



### Multilayer Ceramic Chip Capacitors



Kyocera Ceramic Chip Capacitors are available for different applications as classified below:

Series	Dielectric Options	Typical Applications	Features	Terminations	Available Size
СМ	C0G (NP0) X5R X7R *X6S *X7S Y5V	General purpose	Wide cap range	Nickel barrier	01005, 0201, 0402 0603, 0805, 1206 1210, 1812
СТ	X5R X7R	IC card (Decoupling)	Low profile	Nickel barrier	0201, 0402, 0603 0805, 1206, 1210
CA	X5R	Digital signal Pass line	Reduction in placing cost	Nickel barrier	0405
CL	X7S	ICs (Decoupling)	Low inductance	Nickel barrier	0204, 0306
CF	C0G (NP0) X7R	High voltage & Power circuits	High voltage 250VDC, 630VDC 1000VDC, 2000VDC 3000VDC, 4000VDC	Nickel barrier	0805, 1206, 1210 1812, 2208, 1808 2220
DM	X7R	Automotive	Thermal shock Resistivity High reliability	Nickel barrier	0603,0805,1206

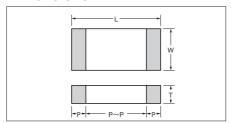
<sup>\*</sup> Negative temperature coefficient dielectric types are available on request.







### **Dimensions**



### **Dimensions and Packaging Quantities**

Size	Co		Dimension			Dimensions (m				Maximum qua			
SIZE	JIS	EIA	Code	L	W	T	P min.	P max.	P to P min.	∮180 Reel	∮330 Reel		
02	0402	01005	Α	0.4±0.02	0.2±0.02	0.2±0.02	0.07	0.14	0.13	40kp (E4/1) 20kp (P8/2)	-		
			_							30kp (P8/1)	150kp (P8/1)		
			Α	0.010.00	0.010.00	0.22 max.	0.40	0.00	0.00	15kp (P8/2)	50kp (P8/2)		
			В	0.6±0.03	0.3±0.03	0.3±0.03	0.10	0.20	0.20	30kp (P8/1)	150kp (P8/1)		
03	0603	0201	В			0.3±0.03				15kp (P8/2)	50kp (P8/2)		
-	0000	0201	С	0.6±0.05	0.3±0.05	0.3±0.05	0.13	0.23	0.19	30kp (P8/1) 15kp (P8/2)	150kp (P8/1)		
			D			0.3±0.09				15kp (P8/2)	50kp (P8/2)		
			E	0.6±0.09	0.3±0.09	0.25 max.	0.10	0.20	0.20	15kp (P8/2)	-		
			Α			0.25 max.				20kp (P8/1)	100kp (P8/1)		
			В			0.33 max.	_			10kp (P8/2) 10kp (P8/2)	50kp (P8/2)		
				1.0±0.05	0.5±0.05		-			20kp (P8/1)	100kp (P8/1)		
			С			0.35 max.				20kp (P8/1) 10kp (P8/2)	50kp (P8/2)		
			D			0.5±0.05				20kp (P8/1)	100kp (P8/1)		
05	1005	0402				0.0=0.00	0.15	0.35	0.30	10kp (P8/2)	50kp (P8/2) 100kp (P8/1)		
			E			0.35 max.				20kp (P8/1) 10kp (P8/2)	50kp (P8/2)		
			F	1.0±0.10	0.5±0.10	0.5±0.10				20kp (P8/1)	• • •		
			F			0.5±0.10				10kp (P8/2)	50kp (P8/2)		
			G	1.0±0.15	0.5±0.15	0.5±0.15				20kp (P8/1)	50kp (P8/2)		
			Α			0.55 max.				10kp (P8/2) 4kp (P8/4)	10kp (P8/4)		
				1.6±0.10	0.8±0.10		1			8kp (P8/2)	20kp (P8/2)		
			В		0.0=0.10	0.8±0.10				4kp (P8/4)	10kp (P8/4)		
			С			0.55 max.				8kp (P8/2)	20kp (P8/2)		
105	1608	0603		1.6±0.15	0.8±0.15		0.20	0.60	0.50	4kp (P8/4)	10kp (P8/4)		
			D			0.8±0.15				8kp (P8/2) 4kp (P8/4)	20kp (P8/2) 10kp (P8/4)		
			Е			0.55 max.				8kp (P8/2)	20kp (P8/2)		
				1.6±0.2	0.8±0.2					4kp (P8/4)	10kp (P8/4)		
			F A			0.8±0.2 0.55 max.				* 4kp (P8/4)	- 10kp (P8/4)		
			B			0.95 max.			-	4kp (P8/4) 4kp (P8/4)	10kp (P8/4)		
			C			1.00 max.	-			4kp (E8/4)	10kp (E8/4)		
			D	2.0±0.10	1.25±0.10	0.60±0.1				4kp (P8/4)	10kp (P8/4)		
			E			0.85±0.10				4kp (P8/4)	10kp (P8/4)		
21	2012	0805	F G			1.05±0.10 1.25±0.10	0.20	0.75	0.70	3kp (E8/4) 3kp (E8/4)	10kp (E8/4) 10kp (E8/4)		
			H			0.55 max.	1			4kp (P8/4)	10kp (P8/4)		
			J	2.0±0.15	1.25±0.15	0.95 max.	]			4kp (P8/4)	10kp (P8/4)		
			K			1.25±0.15				3kp (E8/4)	10kp (E8/4)		
			L M	2.0±0.20	1.25±0.20	0.95 max. 1.25±0.20			-	4kp (P8/4) 3kp (E8/4)	10kp (P8/4) 10kp (E8/4)		
			A			0.85±0.10				4kp (P8/4)	10kp (E8/4)		
			В			0.95 max.				4kp (P8/4)	10kp (P8/4)		
			С	3.2±0.20	1.6±0.15	1.00 max.				4kp (E8/4)	10kp (E8/4)		
			D	0.220.20	1.020.10	1.15±0.10	0.00	0.05	1 40	3kp (E8/4)	10kp (E8/4)		
316	3216	1206	E F			1.25±0.10 1.6±0.15	0.30	0.85	1.40	3kp (E8/4) 2.5kp (E8/4)	10kp (E8/4) 5kp (E8/4)		
			G			0.95 max				4kp (P8/4)	10kp (P8/4)		
			Н	3.2±0.20	1.6±0.20	1.00 max.	]			4kp (E8/4)	10kp (E8/4)		
			J	0.010.00	1.010.00	1.6±0.20	0.50	0.70	1.00	2.5kp (E8/4)	5kp (E8/4)		
			K A	3.2±0.30	1.6±0.30	1.6±0.30 1.00 max.	0.50	0.70	1.90	2kp (E8/4) 4kp (E8/4)	- 10kp (E8/4)		
			B			1.40 max.	1			3kp (E8/4)	10kp (E8/4)		
			C			1.60 max.	-			2.5kp (E8/4)	5kp (E8/4)		
32	3225	1210	D	3.2±0.20	2.5±0.20	1.6±0.15	0.30	1.00	1.40	2.5kp (E8/4)	5kp (E8/4)		
			E			2.20 max.	-		-	2kp (E8/4)	5kp (E8/4)		
			F G			2.0±0.2 2.5±0.2	-		-	2kp (E8/4) 1kp (E8/4)	5kp (E8/4) 4kp (E8/4)		
40	4500	4000	A	4.5.0.00	0.010.00	1.6 max.	0.45	0.05	0.00	2kp (E12/4)	- +KP (L0/4)		
42	4520	1808	В	4.5±0.20	2.0±0.20	2.2 max.	0.15	0.85	2.60	2kp (E12/4)	-		
			A			2.0 max.				1kp (E12/8)	-		
<b>43</b> 453		532 1812	532 1812		В			2.0±0.2				1kp (E12/8)	-
	4532			C D	4.5±0.30	3.2±0.20	2.5 max. 2.5±0.2	0.30	1.10	2.00	0.5kp (E12/8) 0.5kp (E12/8)	-	
			E			2.8 max.	1			0.5kp (E12/8)	-		
			F			2.8±0.2			<u>                                       </u>	0.5kp (E12/8)	-		
52	5720	2208	Α	5.7±0.40	2.0±0.20	2.2 max.	0.15	0.85	4.20	2kp (12/8)	-		
55	5750	2220	A	5.7+0.40	5.0+0.40	2.0 max. 2.5 max.	0.20	1 40	2.50	1kp (E12/8)	-		
	5750	2220	В	5.7±0.40	5.0±0.40	2.5 max. 2.8 max.	0.30	1.40	2.50	0.5kp (E12/8) 0.5kp (E12/8)	-		

Note: Taping denotes the quantity packaged per reel (kp means 1000 pieces).



# Multilayer Ceramic Chip Capacitors Ordering Information



### **KYOCERA PART NUMBER**

<u>CM 21 X7R 104 K 50 A T </u>

### SERIES CODE —

CM = General Purpose CL = ICs

CT = Low Profile CF = High Voltage CA = Arrays DM = Automotive

### SIZE CODE -

SIZE	EIA	(JIS)	SIZE		EIA (JIS)	SIZE	EIA (JIS)
02 =	01005	(0402)	32	=	1210 (3225)	D11 =	0405 (1014)/ 2 cap
03 =	0201	(0603)	42	=	1808 (4520)		
05 =	0402	(1005)	43	=	1812 (4532)		
105 =	0603	(1608)	52	=	2208 (5720)		
21 =	0805	(2012)	55	=	2220 (5750)		
316 =	1206	(3216)					

#### **DIELECTRIC CODE** -

### **CODE EIA CODE**

X/R = X/R Y5V = Y5V

Negative temperature coefficient dielectric types are available on request.

### CAPACITANCE CODE —

Capacitance expressed in pF.

Two significant digits plus number of zeros.

For Values < 10pF, Letter R denotes decimal point,

eg. 100000pF = 104 1.5pF = 1R5  $0.1\mu F = 104$  0.5pF = R50 4700pF = 472  $100\mu F = 107$ 

### TOLERANCE CODE —

$A = \pm 0.05pF$ (option)	$D = \pm 0.5pF$	$K = \pm 10\%$
$B = \pm 0.1 pF$	$G = \pm 2\%$ (option)	$M = \pm 20\%$
$C = \pm 0.25 pF$	$J = \pm 5\%$	7 = -20  to  +80%

### **VOLTAGE CODE** —

04 = 4	1VDC	100 =	100VDC	1000 =	1000VDC
06 = 6	S.3VDC	250 =	250VDC	2000 =	2000VDC
10 = 1	10VDC	400 =	400VDC	3000 =	3000VDC
16 = 1	16VDC	630 =	630VDC	4000 =	4000VDC
25 = 2	25VDC				

35 = 35VDC50 = 50VDC

### TERMINATION CODE —

A = Nickel Barrier/ Tin K = Nickel Barrier/ Au

### PACKAGING CODE —

B = Bulk	H = 7" Reel Taping & 2mm Cavity pitch
C = Bulk Cassette (option)	N = 13" Reel Taping & 2mm Cavity pitch
T = 7" Reel Taping & 4mm or 8mm*1 Cavity pitch	W = 13" Reel Taping & 1mm Cavity pitch
Q = 7" Reel Taping & 1mm Cavity pitch	*P = 7" Reel Taping & 1mm Cavity pitch
L = 13" Reel Taping & 4mm Cavity pitch	* Carrier tape width 4mm.
	*1 Applied for size 43 to 55.

### OPTION —

Thickness max. value is indicated in CT series

EX. 125  $\rightarrow$  1.25mm max. 095  $\rightarrow$  0.95mm max.



# **Multilayer Ceramic Chip Capacitors Temperature Characteristics and Tolerance**



### **Temperature Compensation Type**

Code	ppm	ı/ °C	Temperature Range
CG	0	±30	
CH		±60	
CJ		±120	
CK		±250	−55 to 125°C
UJ	-750	±120	
UK	-730	±250	
SL	+350 to	-1000	

Note: All parts of C0G will be marked as "CG" but will conform to the above table.

Temperature coefficients are determined by calculation based on measurement at 20°C and 85°C.

### **High Dielectric Constant Type**

EIA Dielectric	Temperature Range	∆C max.		
X5R	−55 to 85°C	±15%		
X7R	−55 to 125°C	11370		
* <b>X7S</b>	−55 to 125°C	±22%		
*X6S	−55 to 105°C	±22%		
Y5V	−30 to 85°C	-82 to +22%		

<sup>\*</sup> option

### **Available Tolerances**

Dielectric materials, capacitance values and tolerances are available in the following combinations only:

EIA Dielectric	Tolerance	Capacitance
	*3 A=±0.05pF	<0.5pF
	B=±0.1pF	≤5pF
	C=±0.25pF	*1 <10pF
COG	D=±0.50pF	<10pr
	*3 G=±2%	\10xF
	J=±5%	≥10pF
	K=±10%	E12 Series
*3 X6S X5R	*2 K=±10%	*4 E3 Series
*3 X7S X7R	M=±20%	E3 Series
Y5V	Z=-20% to +80%	E3 Series

#### Note:

### **E Standard Number**

E3	<b>E</b> 6	E12	E24 (C	ption)
	1.0	1.0	1.0	1.1
1.0	1.0	1.2	1.2	1.3
1.0	1.5	1.5	1.5	1.6
	1.5	1.8	1.8	2.0
	0.0	2.2	2.2	2.4
2.2	2.2	2.7	2.7	3.0
2.2	1.0     1.0       1.2     1.2       1.5     1.5       1.8     1.8       2.2     2.2	3.6		
	3.3	3.9	1.2     1.3       1.5     1.6       1.8     2.0       2.2     2.4       2.7     3.0       3.3     3.6       3.9     4.3       4.7     5.1       5.6     6.2       6.8     7.5	4.3
	4.7	4.7	4.7	5.1
4.7	4.7	5.6	1.0     1.1       1.2     1.3       1.5     1.6       1.8     2.0       2.2     2.4       2.7     3.0       3.3     3.6       3.9     4.3       4.7     5.1       5.6     6.2       6.8     7.5	
4.7	6.9	6.8	6.8	7.5
	0.0	8.2	8.2	9.1

<sup>\*1</sup> Nominal values below 10pF are available in the standard values of 0.5pF, 1.0pF, 1.5pF, 2.0pF, 3.0pF, 4.0pF, 5.0pF, 6.0pF, 7.0pF, 8.0pF, 9.0pF

<sup>\*2</sup> J =  $\pm$ 5% for X7R (X5R) is available on request.

<sup>\*3</sup> option

<sup>\*4</sup> E6 series is available on request.





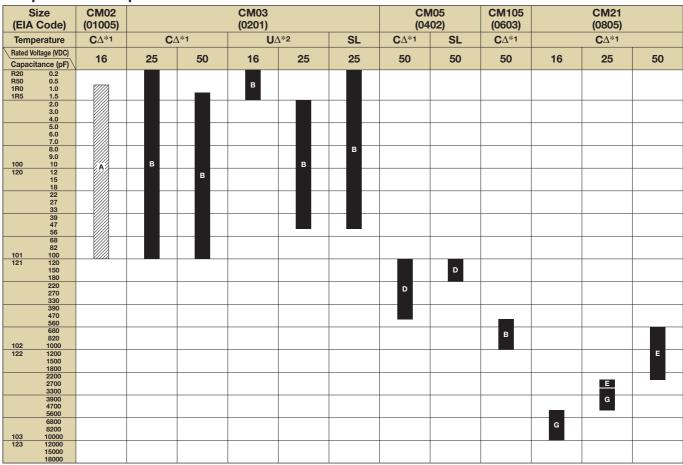
### **Features**

We offer a diverse product line ranging from ultra–compact (0.4×0.2mm) to large (4.5×3.2mm) components configured for a variety of temperature characteristics, rated voltages, and packages. We offer the choice and flexibility for almost any applications.

### **Applications**

This standard type is ideal for use in a wide range of applications, from commercial to industrial equipment.

### **Temperature Compensation Dielectric**



<Standard Capacitance Value>

E12 Series

Please contact for capacitance value other than standard.

Optional Spec.

\*1: CG,CH,CJ,CK

\*1: UG,UF

Alphabets in capacitance chart denote dimensions. Please refer to the below table for detail.

### (Example)

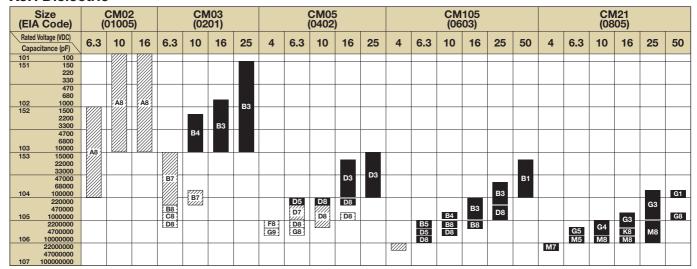
In case of "B" for CM03;

L: 0.6±0.03mm W: 0.3±0.03mm T: 0.3±0.03mm

Size	Size	Dimension (mm)							
Size	Code	L	W	Т					
02	Α	0.4±0.02	0.2±0.02	0.2±0.02					
03	<b>B</b> 0.6±0		0.3±0.03	0.3±0.03					
05	D	1.0±0.05	0.5±0.05	0.5±0.05					
105	В	1.6±0.10	0.8±0.10	0.8±0.10					
21	E	2.0±0.10	1.25±0.10	0.85±0.10					
21	G	2.0±0.10	1.25±0.10	1.25±0.10					



### **X5R Dielectric**



	Size A Code)		CM316 (1206)				CM32 (1210)							143 12)	
	d Voltage (VDC) acitance (pF)	6.3	10	16	25	50	100	4	6.3	10	16	25	50	6.3	50
105	220000 470000 1000000				D3	D1	К3 —					В3	B1 F1		
106	2200000 4700000 10000000	F5	F4	F3	F3 J8	J3 ]				F4	C3	F3 G3	G3		D1
107	22000000 4700000 100000000	J5	J8	J8				G5	G5	G4	<b>G</b> 3	G8		F5	

<Standard Capacitance Value>
CM21 size and smaller : E6 Series
CM216 size and larger / capacitance value of 0.1 vF and larger.

CM316 size and larger / capacitance value of 0.1µF and larger : E3 Series Please contact for capacitance value other than standard.

Optional Spec.

Two digits alphanumerics in capacitance chart denote dimensions and tan  $\delta.$  Please refer to the below table for detail.

#### (Example)

In case of "B2" for CM03; L: 0.6±0.03mm W: 0.3±0.03mm T: 0.3±0.03mm

Tan  $\delta$ : 3.5% max.

Size	Size	Dir	Dimension (mm)							
Size	Code	L	W	Т						
02	Α	0.4±0.02	0.2±0.02	0.2±0.02						
	В	0.6±0.03	0.3±0.03	0.3±0.03						
03	С	0.6±0.05	0.3±0.05	0.3±0.05						
	D	0.6±0.09	0.3±0.09	0.3±0.09						
	D	1.0±0.05	0.5±0.05	0.5±0.05						
05	F	1.0±0.10	0.5±0.10	0.5±0.10						
	G	1.0±0.15	0.5±0.15	0.5±0.15						
105	В	1.6±0.10	0.8±0.10	0.8±0.10						
103	D	1.6±0.15	0.8±0.15	0.8±0.15						
	G	2.0±0.10	1.25±0.10	1.25±0.10						
21	K	2.0±0.15	1.25±0.15	1.25±0.15						
	М	2.0±0.20	1.25±0.20	1.25±0.20						

Size	Size	Dir	nension (m	nm)	
Size	Code	L	W	Т	
	D	3.2±0.20	1.6±0.15	1.15±0.10	
316	F	3.2±0.20	1.6±0.15	1.6±0.15	
310	J	3.2±0.20	1.6±0.20	1.6±0.20	
	K	3.2±0.30	1.6±0.30	1.6±0.30	
	В	3.2±0.20	2.5±0.20	1.40 max.	
32	С	3.2±0.20	2.5±0.20	1.60 max.	
32	F	3.2±0.20	2.5±0.20	2.0±0.2	
	G	3.2±0.20	2.5±0.20	2.5±0.2	
42	D	4.5±0.30	3.2±0.20	2.5±0.2	
43	F	4.5±0.30	3.2±0.20	2.8±0.2	

$\begin{array}{c} \text{Tan } \delta \\ \text{Code} \end{array}$	Tan δ				
1	2.5% max.				
2	3.5% max.				
3	5.0% max.				
4	7.0% max.				
5	7.5% max.				
7	10.0% max.				
8	12.5% max.				
9	20.0% max.				





### X7R Dielectric

	Size ( Code)	CM02 (01005)		CM03 (0201)			105 02)			CM105 (0603)					CM21 (0805)		
	Voltage (VDC)	16	10	16	25	16	25	6.3	10	16	25	50	6.3	10	16	25	50
101 151	100 150 220 330	A8		B2	B2												
102 152	470 680 1000 1500	A8		62													
132	2200 3300 4700		В3 —														
103 153	6800 10000 15000 22000					D2	D3										
104	33000 47000 68000 100000					D8	D8			B2	B2	B1					G1
105	220000 470000 1000000								B3 B8	В8	D8			G3	G2 G8	G2 G8	M3 }
106	2200000 470000 1000000 2200000							D8					M8	M8 [M8]	M8	M8	

	Size CM316 (EIA Code) (1206)						CM32 (1210)					CM43 (1812)		
	oltage (VDC) tance (pF)	6.3	10	16	25	50	100	10	16	25	50	100	50	100
104	47000 100000					A1	D1 F1					B1		
105	220000 470000 1000000			D2	D2 F2	D1				B2	B1 F1	F1 G1	B1	D1
	2200000 4700000 10000000 22000000	J8	F3 J8 J5	J8	J8 J3	[J3]	K3	G8	G2 G8	F2 G8	G3		D1	

Optional Spec.

<Standard Capacitance Value>

CM21 size and smaller : E6 Series

CM316 size and larger / capacitance value of  $0.1\mu\text{F}$  and larger : E3 Series

Please contact for capacitance value other than standard.

Two digits alphanumerics in capacitance chart denote dimensions and tan  $\delta.$ Please refer to the below table for detail.

#### (Example)

In case of "B3" for CM03; L: 0.6±0.03mm W: 0.3±0.03mm T: 0.3±0.03mm Tan  $\delta$ : 5.0% max.

Size	Size	Dir	nension (m	ım)
Size	Code	L	W	Т
02	Α	0.4±0.02	0.2±0.02	0.2±0.02
03	В	0.6±0.03	0.3±0.03	0.3±0.03
05	D	1.0±0.10	0.5±0.10	0.5±0.10
105	В	1.6±0.10	0.8±0.10	0.8±0.10
105	D	1.6±0.15	0.8±0.15	0.8±0.15
21	G	2.0±0.10	1.25±0.10	1.25±0.10
21	М	2.0±0.20	1.25±0.20	1.25±0.20

Size	Size	Dir	nension (m	nm)	
Size	Code	L	W	Т	
	Α			0.85±0.10	
	D	3.2±0.20	1.6±0.15	1.15±0.10	
316	F			1.6±0.15	
	J	3.2±0.20	1.6±0.20	1.6±0.20	
	K	3.2±0.30	1.6±0.30	1.6±0.30	
	В			1.40 max.	
32	F	3.2±0.20	2.5±0.20	2.0±0.2	
	G			2.5±0.2	
43	В	4.5±0.30	3.2±0.20	2.0±0.2	
43	D	4.5±0.50	J.Z±0.Z0	2.5±0.2	

$\begin{array}{c} \text{Tan } \delta \\ \text{Code} \end{array}$	Tan δ
1	2.5% max.
2	3.5% max.
3	5.0% max.
5	7.5% max.
8	12.5% max.

### **X7S Dielectric**

ATO BIGICOLITO									
Size (EIA Code)	CM316 (1206)								
Rated Voltage (VDC) Capacitance (pF)	100								
47000 104 100000									
220000 470000 105 1000000									
2200000 4700000 106 10000000 22000000	КЗ								

Size	Size	Dimension (mm)							
	Code	L	W	Т					
316	K	3.2±0.30	1.6±0.30	1.6±0.30					

$\begin{array}{c} \text{Tan } \delta \\ \text{Code} \end{array}$	Tan $\delta$
3	5.0% max.

Two digits alphanumerics in capacitance chart denote dimensions and tan  $\delta\!.$ Please refer to the below table for detail.







### **Y5V Dielectric**

	Size A Code)	CM05 (0402)	CM (06	105 03)		CM21 (0805)		CM316 (1206)			CM32 (1210)		
	Voltage (VDC)	10	10	16	10	16	25	10	16	25	10	16	25
102 472	1000 2200 4700												
103 473	10000 22000 47000												
104 474	100000 220000 470000	D8		B6									
105 475	1000000 2200000 4700000		B8 }	Во	G8	G6	G4		D6	D4			
106 476	10000000 22000000 47000000				<b>G</b> 9			F8 F9	F6		F8	C6	C6

<Standard Capacitance Value>

E3 Series

Please contact for capacitance value other than standard.

Optional Spec.

Two digits alphanumerics in capacitance chart denote dimensions and tan  $\delta.$  Please refer to the below table for detail.

#### (Example)

In case of "C8" for CM05;

L : 1.0±0.05mm W: 0.5±0.05mm T : 0.5±0.05mm Tan δ: 12.5% max.

Size	Size	Dimension (mm)					
Size	Code	L	W	Т			
05	D	1.0±0.05	0.5±0.05	0.5±0.05			
105	В	1.6±0.10	0.8±0.10	0.8±0.10			
21	G	2.0±0.10	1.25±0.10	1.25±0.10			
316	D	3.2±0.20	1.6±0.15	1.15±0.10			
310	F	3.2±0.20	1.6±0.15	1.6±0.15			
32	С	3.2±0.20	2.5±0.20	1.60 max.			
32	F	3.2±0.20	2.5±0.20	2.0±0.2			

$\begin{array}{c} \text{Tan } \delta \\ \text{Code} \end{array}$	Tan δ
3	5.0% max.
4	7.0% max.
6	9.0% max.
8	12.5% max.
9	16.0% max.





## Test Conditions and Specifications for Temperature Compensation Type (C $\triangle$ to U $\triangle$ • SL Characteristics) CM/ CT/ CF Series

Test Items			Test Condition	ıs	Specifications		
Capacitance V	/alue (C)	Capacitano		Volt	Within tolerance		
Q		C≤1000pF C>1000pF		0.5 to 5Vrms	C≥30pF: Q≥1000 C<30pF: Q≥400+20C		
Insulation Resistance (IR)		Measured after the rated voltage is applied for 1 minute at room ambient.  For the rated voltage of over 630V, apply 500V for 1 minute at room ambient.  The charge and discharge current of the capacitor must not exceed 50mA.			Over 10000M $\Omega$ or 500M $\Omega$ • $\mu$ F, whichever is less		
Dielectric Res	istance	Apply 3 times of the rated voltage for 1 to 5 seconds. Apply 1.5 times when the rated voltage is 250V or over. Apply 1.2 times when the rated voltage is 630V or over. The charge and discharge current of the capacitor must			No problem observed		
Appearance		Microscope			No problem observed		
Termination S	trength		ard force of 500g ( le. Apply 2N for 0	,	No problem observed		
Bending Stren	gth	Glass epoxy PC time 10 seconds	B: Fulcrum spacin s.	g: 90mm, duration	No significant damage at 1mm bent		
Vibration	Appearance		ency: 10 to 55 (Hz	·)	No problem observed		
Test	ΔC	Amplitude: 1.5	mm lition: 10→55→10	Hz/ 1 minute in X.	Within Tolerance		
	Q	Y and Z	ours each, 6 hours	•	C≥30pF : Q≥1000 C<30pF : Q≥400+20C		
Soldering	Appearance	Soak the sample in 260°C±5°C solder for 10±0.5			No problem observed		
Heat Resistance	ΔC	seconds and place in room ambient, and measure after 24±2 hours.			Within ±2.5% or ±0.25pF, whichever is larger		
riesistance	Q	(Pre-heating conditions)			C≥30pF : Q≥1000		
		Order	Temperature	Time	C<30pF: Q≥400+20C		
	IR	2	80 to 100°C 150 to 200°C	2 minutes 2 minutes	Over $10000M\Omega$ or $500M\Omega$ • $\mu F$ whichever is less		
	Withstanding Voltage	The charge and discharge current of the capacitor must not exceed 50mA for IR and withstanding voltage measurement.		nt of the capacitor	Resist without problem		
Solderablity		Sn-3Ag-0.5Cu         245±5°C         3±0.5 sec.           Sn63 Solder         235±5°C         2±0.5 sec.			Solder coverage : 90% min.		
Temperature	Appearance	(Cycle)			No problem observed		
Cycle	ΔC	Room temperature (3min.)→ Lowest operation temperature (30min.)→ Room temperature (3min.)→			Within ±2.5% or ±0.25pF, whichever is larger		
	Q				C≥30pF : Q≥1000 C<30pF : Q≥400+20C		
	IR	Highest operati	ion temperature(3	0min.)	Over 10000M $\Omega$ or 500M $\Omega$ • $\mu\text{F},$ whichever is less		
	Withstanding Voltage  After 5 cycles, measure after 24±2 hours.  The charge and discharge current of the capacitor must not exceed 50mA for IR and withstanding voltage measurement.		Resist without problem				
Load	Appearance	After applying i	rated voltage for 5	600+12/ -0 hours	No problem observed		
Humidity Test	ΔC		n at 40°C±2°C, hu	•	Within ±7.5% or ±0.75pF, whichever is larger		
(Except CF Series)	Q	room temperat	parts to stabilize f ure before measu I discharge currer	rement.	C≥30pF : Q≥200		
	IR		ed 50mA for IR me		Over $500M\Omega$ or $25M\Omega$ • $\mu\text{F}$ , whichever is less		
High-	Appearance	After applying t	wice the rated vo	Itage at the	No problem observed.		
Temperature with Loading	ΔC	temperature of	125±3°C for 1000	)+12/ -0 hours,	Within ±3% or ±0.3pF, whichever is larger		
With Loading		measure the sample after 24±2 hours.  Apply 1.5 times when the rated voltage is 250V or over.  Apply 1.2 times when the rated voltage is 630V or over.  The charge and discharge current of the capacitor			C≥30pF: Q≥350 10pF <c<30pf: 2<="" q≥275+5c="" th=""></c<30pf:>		
	Q			•	0.40=5.0>000.400		

Please ask for individual specification for the hatched range in previous chart.





## Test Conditions and Specifications for High Dielectric Type (X5R, X7R) CM/ CT/ CA Series

Test	Items	Test Conditions	Specifications	
Capacitance V	/alue (C)	Measure after heat treatment	Within tolerance	
Tanδ (%)			Refer to capacitance chart	
Insulation Res	istance (IR)	Measured after the rated voltage is applied for 1 minute at room ambient. The charge and discharge current of the capacitor must not exceed 50mA.	Over 10000M $\Omega$ or 500M $\Omega$ • $\mu$ F, whichever is less	
Dielectric Res	istance	Apply 2.5 times of the rated voltage for 1 to 5 second The charge and discharge current of the capacit must not exceed 50mA.		
Appearance		Microscope	No problem observed	
Termination St	trength	Apply a sideward force of 500g (5N) to a PCB-mounted sample. note: 2N for 0201 size in for 01005 size. Exclude CT series with thickness of less than 0.66mn	No problem observed	
Bending Stren	gth	Glass epoxy PCB: Fulcrum spacing: 90mm, duration time 10 seconds.  Exclude CT series with thickness of less than 0.66mn	No significant damage at 1mm bent	
Vibration	Appearance	Take the initial value after heat treatment.	No problem observed	
Test	ΔC	Vibration frequency: 10 to 55 (Hz) Amplitude: 1.5mm	Within tolerance	
	Tanδ (%)	Sweeping condition: 10→55→10Hz/1 minute in X, Y and Z Directions: 2 hours each, 6 hours total.	Within tolerance	
Soldering	Appearance	Take the initial value after heat treatment.	No problem observed	
Heat Resistance	ΔC	Soak the sample in 260°C±5°C solder for 10±0 seconds and place in room ambient, and measurements	VIIIIII 1 1 . 3 70	
nesistance	Tanδ (%)	after 24±2 hours.	Within tolerance	
	IR	(Pre-heating conditions)	Over $10000M\Omega$ or $500M\Omega$ • $\mu\text{F}$ , whichever is less	
	Withstanding Voltage  Order Temperature Time 1 80 to 100°C 2 minutes 2 150 to 200°C 2 minutes The charge and discharge current of the capacitor must not		Resist without problem	
Solderablity		exceed 50mA for IR and withstanding voltage measurement Soaking condition  Sn-3Ag-0.5Cu 245±5°C 3±0.5 sec. Sn63 Solder 235±5°C 2±0.5 sec.	Solder coverage : 90% min.	
Temperature	Appearance	Take the initial value after heat treatment.	No problem observed	
Cycle	ΔC	(Cycle) Room temperature (3min.)→	Within ±7.5%	
	Tanδ (%)	Lowest operation temperature (30min.)→	Within tolerance	
	IR	Room temperature (3min.)→ Highest operation temperature(30min.)	Over $10000 \mathrm{M}\Omega$ or $500 \mathrm{M}\Omega$ • $\mu\mathrm{F}$ , whichever is less	
	Withstanding Voltage	After 5 cycles, measure after 24±2 hours. The charge and discharge current of the capacitor must no exceed 50mA for IR and withstanding voltage measurement	nt.	
Load	Appearance	Take the initial value after voltage treatment.	No problem observed	
Humidity Test	ΔC	After applying rated voltage for 500+12/ -0 hour in pre-condition at 40°C±2°C, humidity 90 to	WIUIII ±12.370	
1031	Tanδ (%)	95%RH, allow parts to stabilize for 24±2 hours,	at 200% max. of initial value	
	IR	room temperature before measurement. The charge and discharge current of the capacit must not exceed 50mA for IR measurement.	or Over $500 \text{M}\Omega$ or $25 \text{M}\Omega$ • $\mu\text{F}$ , whichever is less	
High-	Appearance	Take the initial value after voltage treatment.	No problem observed	
Temperature	ΔC	After applying twice the rated voltage at the higher operation temperature for 1000+12/-0 hours,	St Within ±12.5%	
with Loading	Tan $\delta$ (%)	measure the sample after 24±2 hours.	200% max. of initial value	
Loading	IR	The charge and discharge current of the capacit must not exceed 50mA for IR measurement. Apply 1.5 times when the rated voltage is 10V or less. Applied voltages for respective products are indicated in the below char	Over 1000M $\Omega$ or 50M $\Omega$ • $\mu$ F, whichever is less	

Pre-treat-	Heat	Keep specimen at 150+0/ –10°C for 1 hour, leave specimen at room ambient for 24±2 hours.
ment	Voltage	Apply the same test condition for 1 hour, then leave the specimen at room ambient for 24±2 hours.

High-temperature with Loading Applied Voltage (Rated Voltage × □ )

Applied Voltage	Rated Voltage	Products
	4V	CT03X5R104
×1.3	6.3V	CM105X5R475, CM316X5R476
	0.30	CT05X5R104, CT21X5R106, CT03X5R104
	16V	CM105X7R474-105, CM21X7R105-475, CM316X7R475-106, CM32X7R106-226, CM05X5R224, CM105X5R225, CM21X5R475-106, CM316X5R226
	100	CT105X5R105, CT21X5R225-475, CT316X5R106, CM03X5R332-103
	25V	CM105X7R474, CM21X7R105-225, CM316X7R475, CM32X7R106, CM105X5R474-105, CM21X5R225-106, CM316X5R106, CM32X5R106-226
×1.5	250	CT316X5R225-106, CM03X5R152-103
	50V	CM21X5R105, CM32X5R106, CM32X7R106
	500	CT21X5R225, CT316X5R105-475
	100V	CM32X7RK74, CM43X7R105





## Test Conditions and Specifications for High Dielectric Type (Y5V) CM/ CT/ CA Series

Test	Test Items		Test Conditions			Specifications		
Capacitance V	/alue (C)	Measure after heat treatment			Within tolerance			
Tanδ (%)		Frequency Volt 1kHz±10% 1.0±0.2Vrms		Volt 0.2Vrms	Refer to capacitance chart			
Insulation Res	sistance (IR)	Measured after the rated voltage is applied for 1 minute at room ambient.		pplied for 1	Over 10000M $\Omega$ or 500M $\Omega$ • $\mu$ F, whichever is less			
Dielectric Res	istance	Apply 2.5 times of the rated voltage for 1 to 5 seconds. The charge and discharge current of the capacitor must not exceed 50mA.				No problem observed		
Appearance		Microscope				No problem observed		
Termination S	trength	mounted sar	mple.		(5N) to a PCB- s than 0.66mm.	No problem observed		
Bending Stren	ngth	time 10 seco	nds.		90mm, duration s than 0.66mm.	No significant damage at 1mm bent		
Vibration	Appearance	Take the initi			tment.	No problem observed		
Test	ΔC	Vibration free Amplitude: 1		to 55 (Hz)		Within tolerance		
	Tanδ (%)	Sweeping condition: 10→55→10Hz/ 1 minute in X, Y and Z Directions: 2 hours each, 6 hours total.			,	Within tolerance		
Soldering	Appearance	Take the initi				No problem observed		
Heat Resistance	ΔC				older for 10±0.5 nt, and measure	\\/ithin +200/		
110010101100	Tanδ (%)	after 24±2 ho	ours.		.,	Within tolerance		
	IR	(Pre-heating conditions)  Order Temperature Time			Time	Over $10000M\Omega$ or $500M\Omega$ • $\mu\text{F}$ , whichever is less		
	Withstanding Voltage	1 80 to 100°C 2 150 to 200°C  The charge and discharge current o must not exceed 50mA for IR and voltage measurement.			Resist without problem			
Solderablity		Soaking condition           Sn-3Ag-0.5Cu         245±5°C         3±0.5 sec.           Sn63 Solder         235±5°C         2±0.5 sec.			Solder coverage : 90% min.			
Temperature	Appearance	Take the initi	al value afte	er heat treat	tment.	No problem observed		
Cycle	ΔC	(Cycle) Room tempe	erature (3mi	n.)→		Within ±20%		
	Tanδ (%)	Lowest oper	ation tempe	erature (30n	nin.)→	Within tolerance		
	IR	Room tempe Highest oper			nin.)	Over 10000M $\Omega$ or 500M $\Omega$ • $\mu$ F, whichever is less		
	Withstanding Voltage	After 5 cycle The charge a must not exc voltage mea	and dischar ceed 50mA	ge current o	of the capacitor	Resist without problem		
Load	Appearance	Take the initi		0		No problem observed		
Humidity Test	ΔC	After applyin in pre-condit	-	•	0+12/ -0 hours dity 90 to	Within ±30%		
	Tanδ (%)	95%RH, allo			24±2 hours, at	150% max. of initial value		
	IR		and dischar	ge current o	of the capacitor	Over 500M $\Omega$ or 25M $\Omega$ • $\mu$ F, whichever is less		
High-	Appearance	Take the initi		_		No problem observed		
Temperature with	ΔC	After applyin operation ter	0		ge at the highest -0 hours,			
Loading	Tanδ (%)	measure the	sample after	er 24±2 hou	rs.	150% max. of initial value		
		measure the sample after 24±2 hours.  The charge and discharge current of the capacitor			•	Over 1000M $\Omega$ or 50M $\Omega$ • $\mu$ F, whichever is less		
	IR	must not exc	ceed 50mA	must not exceed 50mA for IR measurement.				
Pre-treat-	IR Heat					eave specimen at room ambient for 24±2 hours.		



ment

Voltage

# **Multilayer Ceramic Chip Capacitors Test Conditions and Standards**



## Test Conditions and Specifications for High Dielectric Type (X7R) CF Series

Test Items		Test Conditions	Specifications		
Capacitance \	/alue (C)	Measure after heat treatment	Within tolerance		
Tanδ (%)		CapacitanceFrequencyVoltC≤10μF1kHz±10%1.0±0.2Vrms	Within ±2.5%		
Insulation Resistance (IR)		Measured after the rated voltage is applied for 1 minute at room ambient. Measured after the 500V is applied for 1 minute at room ambient for the rated voltage over 630V. The charge and discharge current of the capacitor must not exceed 50mA.	Over 10000MΩ or 500MΩ • μF, whichever is less Over 100MΩ • μF for CF316X7R104/ 250V and CF43X7R474/ 250V CF55X7R105/ 250V and CF55X7R224/ 630V		
Dielectric Res	sistance	Apply 1.5 times when the rated voltage is 250V or over, apply 1.2 times when the rated voltage is 630V or over for 1 to 5 seconds. The charge and discharge current of the capacitor must not exceed 50mA.	No problem observed		
Appearance		Microscope	No problem observed		
Termination S	trength	Apply a sideward force of 500g (5N) to a PCB-mounted sample.	No problem observed		
Bending Strer	ngth	Glass epoxy PCB: Fulcrum spacing: 90mm, duration time 10 seconds.	No significant damage at 1mm bent		
Vibration Test			No problem observed		
iest	ΔC	Vibration frequency: 10 to 55 (Hz) Amplitude: 1.5mm	Within tolerance		
	Tanδ (%)	Sweeping condition: 10→55→10Hz/ 1 minute in X, Y and Z Directions: 2 hours each, 6 hours total.	Within tolerance		
Soldering Appearance		Take the initial value after heat treatment. Soak the sample in 260°C±5°C solder for	No problem observed		
Heat Resistance	ΔC	10±0.5 seconds and place in room ambient,	Within ±7.5%		
	Tanδ (%)	and measure after 24±2 hours. (Pre-heating conditions)	Within tolerance		
	IR	Order         Temperature         Time           1         80 to 100°C         2 minutes           2         150 to 200°C         2 minutes	Over 10000M $\Omega$ or 500M $\Omega$ • $\mu$ F, whichever is less Over 100M $\Omega$ • $\mu$ F for CF316X7R104/ 250V and CF43X7R474/ 250V CF55X7R105/ 250V and CF55X7R224/ 630V		
	Withstanding Voltage	The charge and discharge current of the capacitor must not exceed 50mA for IR and withstanding voltage measurement.			
Solderablity		Soaking condition           Sn-3Ag-0.5Cu         245±5°C         3±0.5 sec.           Sn63 Solder         235±5°C         2±0.5 sec.	Solder coverage : 90% min.		
Temperature	Appearance	Take the initial value after heat treatment.	No problem observed		
Cycle	ΔC	(Cycle) Room temperature (3min.)→	Within ±7.5%		
	Tanδ (%)	Lowest operation temperature (30min.)→	Within tolerance		
	IR	Room temperature (3min.)→ Highest operation temperature(30min.) After 5 cycles, measure after 24±2 hours. The charge and discharge current of the	Over $10000M\Omega$ or $500M\Omega$ • $\mu$ F, whichever is less Over $100M\Omega$ • $\mu$ F for CF316X7R104/ 250V and CF43X7R474/ 250V CF55X7R105/ 250V and CF55X7R224/ 630V		
	Withstanding Voltage	capacitor must not exceed 50mA for IR and withstanding voltage measurement.	Resist without problem		
High-	Appearance	Take the initial value after voltage treatment.	No problem observed		
Temperature with	ΔC	After applying specified voltage at the highest operation temperature for 1000+12/ -0 hours,	Within ±12.5%		
Loading	Tanδ (%)	then measure the sample after 24±2 hours. The applied voltage shall be;	200% max. of initial value		
	IR	1.5 times the rated voltage when the rated voltage is 250V or over.  1.2 times when the rated voltage is 630V or over.  The charge and discharge current of the capacitor must not exceed 50mA for IR measurement.	Over 1000M $\Omega$ or 50M $\Omega$ • $\mu$ F, whichever is less		
Pre-treat-	Heat	Keep specimen at 150+0/ -10°C for 1 hour. I	leave specimen at room ambient for 24±2 hours.		
mont	Voltors	Application and the secondary for the control of th	- land the superior of decomposition for 0410 km see		

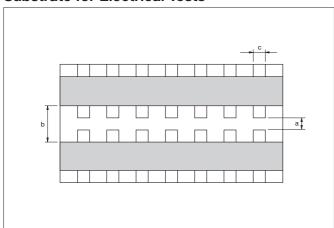
Apply the same test condition for 1 hour, then leave the specimen at room ambient for 24±2 hours.





(Unit: mm)

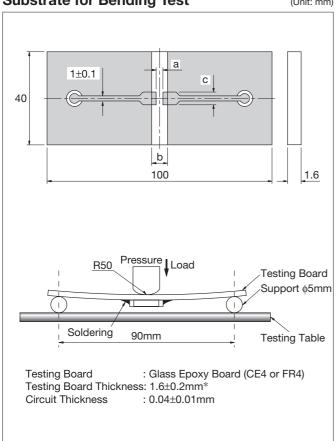
### **Substrate for Electrical Tests**



Size (EIA Code)	а	b	С
02 (01005)	0.15	0.50	0.20
03 (0201)	0.26	0.92	0.32
05 (0402)	0.4	1.4	0.5
105 (0603)	1.0	3.0	1.2
21 (0805)	1.2	4.0	1.65
316 (1206)	2.2	5.0	2.0
32 (1210)	2.2	5.0	2.9
42 (1808)	3.5	7.0	3.7
43 (1812)	3.5	7.0	3.7
52 (2208)	4.5	8.0	5.6
55 (2220)	4.5	8.0	5.6

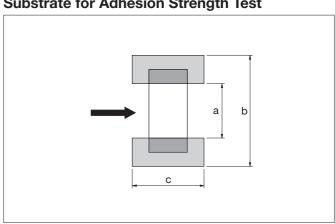
### **Substrate for Bending Test**





### \* 02, 03, 05 and array: 0.8±0.1mm

### **Substrate for Adhesion Strength Test**



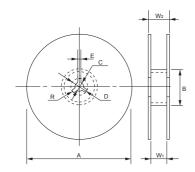


# **Multilayer Ceramic Chip Capacitors Packaging Options**

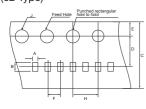


### **Tape and Reel**

• Reel

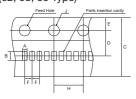


### F=1mm (02 Type)



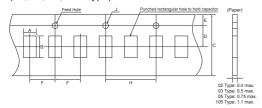


F=1mm (02, 03, 05 Type)

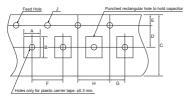


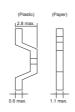


F=2mm (02, 03, 05, 105 Type)

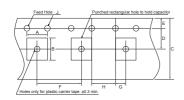


F=4mm (105, D11, 21, 316, 32, 42, 52 Type)





F=8mm (43, 55 Type)





### Reel

(Unit: mm)

Code Reel	Α	В	С	D	
7-inch Reel (CODE: T, H, Q)	180 +0 -2.0				
7-inch Reel (CODE: P)	178±2.0	φ60 min.	13±0.5	21±0.8	
13-inch Reel (CODE: L, N, W)	330±2.0				
Code Reel	E	<b>W</b> 1	W <sub>2</sub>	R	
7-inch Reel (CODE: T, H, Q)		10.5±1.5	16.5 max.		
7-inch Reel (CODE: P)	2.0±0.5	4.35±0.3	6.95±1.0	1.0	
13-inch Reel (CODE: L, N, W)		9.5±1.0	16.5 max.		

<sup>\*</sup> Carrier tape width 8mm.

### **Carrier Tape**

(Unit: mm

Oarrier Tape			(Onit: mm)
Size (EIA Code)	Α	В	F
02 (01005)*	0.23±0.02	0.43±0.02	1.0±0.02
02 (01005)	0.25±0.03	0.45±0.03	2.0±0.05
03 (0201)*	0.37±0.03	0.67±0.03	1.0±0.05
03 (0201)	0.37±0.03	0.67±0.03	2.0±0.05
05 (0402)*	0.65±0.1	1.15±0.1	1.0±0.05
05 (0402)	0.65±0.1	1.15±0.1	2.0±0.05
105 (0603)	1.0±0.2	1.8±0.2	4.0±0.1
21 (0805)	1.5±0.2	2.3±0.2	4.0±0.1
316 (1206)	2.0±0.2	3.6±0.2	4.0±0.1
32 (1210)	2.9±0.2	3.6±0.2	4.0±0.1
42 (1808)	2.4±0.2	4.9±0.2	4.0±0.1
43 (1812)	3.6±0.2	4.9±0.2	8.0±0.1
52 (2208)	2.4±0.2	6.0±0.2	4.0±0.1
55 (2220)	5.3±0.2	6.0±0.2	8.0±0.1
D11 (0405)	1.15±0.2	1.55±0.2	4.0±0.1

<sup>\*</sup> Option

(Unit: mm)

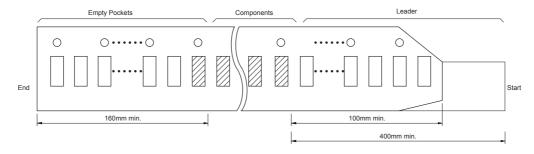
F	Carrier Tape	С	D	Е	G	Н	J				
1.0 ±0.02	4mm Plastic	4.0 +0.08	1.8 ±0.02	0.9 ±0.05	_	2.0 ±0.04	0.8 ±0.04				
1.0 ±0.05	1mm Paper	8.0 +0.3/ –0.1				4.0 ±0.05					
2.0 ±0.05	8mm		3.5 ±0.05								
	Paper	8.0 ±0.3					1.7	1.75	2.0		1.5
4.0 ±0.1	8mm Plastic			±0.1	±0.05	4.0 ±0.1	+0.1/ -0				
	12mm	12.0	5.5								
8.0 ±0.1	Plastic	±0.3	±0.05								

For size 42 (1808) or over, Tape width 12mm and W1: 14±1.5, W2: 18.4mm max.

# **Multilayer Ceramic Chip Capacitors Packaging Options**



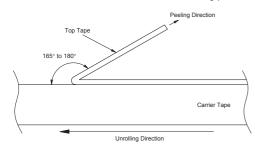
### **Detail of leader and trailer**

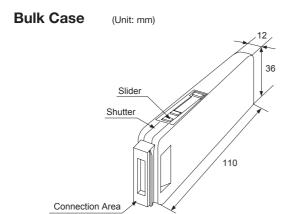


### Adhesive tape

- 1) The exfoliative strength when peeling off the top tape from the carrier tape by the method of the following figure shall be \*0.1 to 0.7N. \*02 Size: 0.1 to 0.5N
- 2) When the top tape is peeled off, the adhesive stays on the top tape.
- 3) Chip capacitors will be in a state free without being stuck on the thermal adhesive tape.

Exfoliating angle: 165 to 180 degrees to the carrier tape Exfoliating speed: 300 mm/min.





• Please contact Kyocera for details.



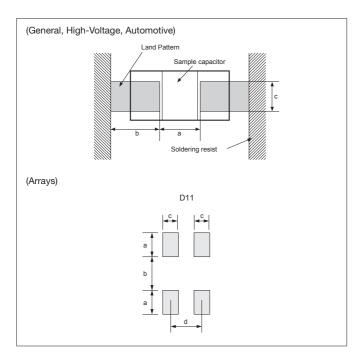
### Multilayer Ceramic Chip Capacitors Surface Mounting Information



### **Dimensions for recommended typical land**

Since the amount of solder (size of fillet) to be used has direct influence on the capacitor after mounting, the sufficient consideration is necessary.

When the amounts of solder is too much, the stress that a capacitor receives becomes larger. It may become the cause of a crack in the capacitor. When the land design of printed wiring board is considered, it is necessary to set up the form and size of land pattern so that the amount of solder is suitable.



### **Design of printed circuit and Soldering**

The recommended fillet height shall be 1/2 of the thickness of capacitors or 0.5mm. When mounting two or more capacitors in the common land, it is necessary to separate the land with the solder resist strike so that it may become the exclusive land of each capacitor.

### General, High-Voltage

(Unit: mm)

Size (EIA Code)	L×W	а	b	С
02 (01005)	0.4×0.2	0.13 to 0.20	0.12 to 0.18	0.20 to 0.23
03 (0201)	0.6×0.3	0.20 to 0.30	0.25 to 0.35	0.30 to 0.40
05 (0402)	1.0×0.5	0.30 to 0.50	0.35 to 0.45	0.40 to 0.60
105 (0603)	1.6×0.8	0.70 to 1.00	0.80 to 1.00	0.60 to 0.80
21 (0805)	2.0×1.25	1.00 to 1.30	1.00 to 1.20	0.80 to 1.10
316 (1206)	3.2×1.6	2.10 to 2.50	1.10 to 1.30	1.00 to 1.30
32 (1210)	3.2×2.5	2.10 to 2.50	1.10 to 1.30	1.90 to 2.30
42 (1808)	4.5×2.0	2.50 to 3.20	1.80 to 2.30	1.50 to 1.80
43 (1812)	4.5×3.2	2.50 to 3.20	1.80 to 2.30	2.60 to 3.00
52 (2208)	5.7×2.0	4.20 to 4.70	2.00 to 2.50	1.50 to 1.80
55 (2220)	5.7×5.0	4.20 to 4.70	2.00 to 2.50	4.20 to 4.70

### **Automotive**

(Unit: mm)

Size (EIA Code)	L×W	а	b	С
105 (0603)	1.6×0.8	0.60 to 0.90	0.80 to 1.00	0.70 to 1.00
21 (0805)	2.0×1.25	0.90 to 1.20	0.80 to 1.20	0.90 to 1.40
316 (1206)	3.2×1.6	1.40 to 1.90	1.00 to 1.30	1.30 to 1.80

### **Arrays**

(Unit: mm)

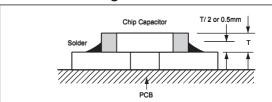
	а	b	С	d
D11 (0405)	0.69	0.28	0.3	0.64

### IC

(Unit: mm)

Size (EIA Code)	L×W	а	b	С
05 (0402)	0.5×1.0	0.15 to 0.20	0.20 to 0.30	0.90 to 1.20
105 (0603)	0.8×1.6	0.20 to 0.30	0.30 to 0.50	1.40 to 1.60

### **Ideal Solder Height**



Item	Not recommended example	Recommended example/ Separated by solder	
Multiple parts mount		Solder resist	
Mount with leaded parts	Leaded parts	Solder resist  Leaded parts	
Wire soldering after mounting	Soldering iron Wire	Solder resist	
Overview Solder resist		Solder resist	



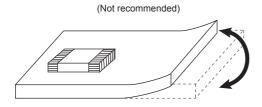
# Multilayer Ceramic Chip Capacitors Surface Mounting Information

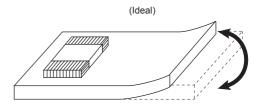


### **Mounting Design**

The chip could crack if the PCB warps during processing after the chip has been soldered.

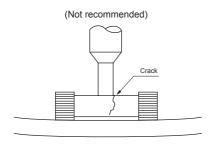
### Recommended chip position on PCB to minimize stress from PCB warpage

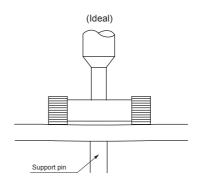




### **Actual Mounting**

- 1) If the position of the vacuum nozzle is too low, a large force may be applied to the chip capacitor during mounting, resulting in cracking.
- 2) During mounting, set the nozzle pressure to a static load of 100 to 300 gf.
- 3) To minimize the shock of the vaccum nozzle, provide a support pin on the back of the PCB to minimize PCB flexture.





- 4) Bottom position of pick up nozzle should be adjusted to the top surface of a substrate which camber is corrected.
- 5) To reduce the possibility of chipping and cracks, minimize vibration to chips stored in a bulk case.
- 6) The discharge pressure must be adjusted to the part size. Verify the pressure during setup to avoid fracturing or cracking the chips capacitors.

### **Resin Mold**

- 1) If a large amount of resin is used for molding the chip, cracks may occur due to contraction stress during curing. To avoid such cracks, use a low shrinkage resin.
- 2) The insulation resistance of the chip will degrade due to moisture absorption. Use a low moisture absorption resin.
- 3) Check carefully that the resin does not generate a decomposition gas or reaction gas during the curing process or during normal storage. Such gases may crack the chip capacitor or damage the device itself.



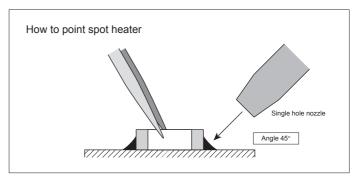
### **Multilayer Ceramic Chip Capacitors Surface Mounting Information**



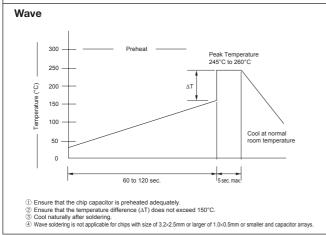
### **Soldering Method**

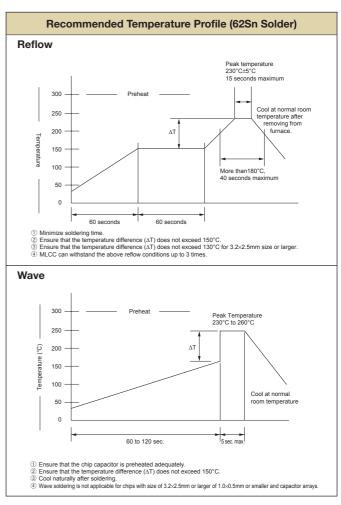
- 1) Ceramic is easily damaged by rapid heating or cooling. If some heat shock is unavoidable, preheat enough to limit the temperature difference (Delta T) to within 130 degree Celsius.
- 2) The product size 1.6×0.8mm to 3.2×1.6mm can be used in reflow and wave soldering, and the product size of bigger than 3.2×1.6mm, or smaller than 1.6×0.8mm, and capacitor arrays can be used in reflow.
  - Circuit shortage and smoking can be created by using capacitors which are used neglecting the above caution.
- 3) Please see our recommended soldering conditions.
- 4) In case of using Sn-Zn Solder, please contact us in advance.
- 5) The following condition is recommended for spot heater application.
- · Recommended spot heater condition

Item	Condition	
Distance	5mm min.	
Angle	45°	
Projection Temp.	400°C max.	
Flow rate	Set at the minimum	
Nozzle diameter	2φ to 4φ (Single hole type)	
Application time	10 sec. max. (1206 and smaller) 30 sec.max. (1210 and larger)	



## Recommended Temperature Profile (Sn-3Ag-0.5Cu) Reflow 250°C±5°C 300 250 200 170 to 180°C 150 220°C max 90 sec. max 90+30 sec ) Minimize soldering time. Ensure that allowable temperature difference does not exceed 150°C. Ensure that allowable temperature difference does not exceed 130°C for 3.2×2.5mm size or larger Wave





### Soldering iron

1) Temperature of iron chip

1210 and larger 280°C max.

3 sec. max.

2) Wattage

3) Tip shape of soldering iron \$3.0mm max.

4) Soldering Time

1206 and smaller 350°C max. 5) Cautions

80W max.

a) Pre-heating is necessary rapid heating must be avoided.

Delta T≤150°C

- b) Avoid direct touching to capacitors.
- c) Avoid rapid cooling after soldering. Natural cooling is recommended.
- \*Consult as if it is difficult to keep the temperature 280°C max. for 1210 and larger MLCC'S.



## Multilayer Ceramic Chip Capacitors Precautions



### **Circuit Design**

- 1. Once application and assembly environments have been checked, the capacitor may be used in conformance with the rating and performance which are provided in both the catalog and the specifications. Use exceeding that which is specified may result in inferior performance or cause a short, open, smoking, or flaming to occur, etc.
- 2. Please consult the manufacturer in advance when the capacitor is used in devices such as: devices which deal with human life, i.e. medical devices; devices which are highly public orientated; and devices which demand a high standard of liability.
  Accident or malfunction of devices such as medical devices, space equipment and devices having to do with atomic power could generate grave consequence with respect to human lives or, possibly, a portion of the public. Capacitors used in these devices may require high reliability design different from that of general purpose capacitors.
- 3. Please use the capacitors in conformance with the operating temperature provided in both the catalog and the specifications.
  Be especially cautious not to exceed the maximum temperature. In the situation the maximum temperature set forth in both the catalog and specifications is exceeded, the capacitor's insulation resistance may deteriorate, power may suddenly surge and short-circuit may occur.
  The capacitor has a loss, and may self-heat due to equivalent series resistance when alternating electric current is passed therethrough. As this effect becomes especially pronounced in high frequency circuits, please exercise caution.
  When using the capacitor in a (self-heating) circuit, please make sure the surface of the capacitor remains under the maximum temperature for usage. Also, please make certain temperature rises remain below 20°C.
- 4. Please keep voltage under the rated voltage which is applied to the capacitor. Also, please make certain the peak voltage remains below the rated voltage when AC voltage is super-imposed to the DC voltage.
  In the situation where AC or pulse voltage is employed, ensure average peak voltage does not exceed the rated voltage.
  Exceeding the rated voltage provided in both catalog and specifications may lead to defective withstanding voltage or, in worst case situations, may cause the capacitor to smoke or flame.
- 5. When the capacitor is to be employed in a circuit in which there is continuous application of a high frequency voltage or a steep pulse voltage, even though it is within the rated voltage, please inquire to the manufacturer.
  In the situation the capacitor is to be employed using a high frequency AC voltage or a extremely fast rising pulse voltage, even though it is within the rated voltage, it is possible capacitor reliability will deteriorate.
- 6. It is a common phenomenon of high-dielectric products to have a deteriorated amount of static electricity due to the application of DC voltage.

  Due caution is necessary as the degree of deterioration varies depending on the quality of capacitor materials, capacity, as well as the load voltage at the time of operation.
- 7. Do not use the capacitor in an environment where it might easily exceed the respective provisions concerning shock and vibration specified in the catalog and specifications.
  In addition, it is a common piezo phenomenon of high dielectric products to have some voltage due to vibration or to have noise due to voltage change. Please contact sales in such case.
- 8. If the electrostatic capacity value of the delivered capacitor is within the specified tolerance, please consider this when designing the respective product in order that the assembled product function appropriately.
- 9. Please contact us upon using conductive adhesives.

### **Storage**

- 1. If the component is stored in minimal packaging (a heat–sealed or zippered plastic bag), the bag should be kept closed. Once the bag has been opened, reseal it or store it in a desiccator.
- 2. Keep storage place temperature +5 to +40 degree C, humidity 20 to 70% RH.
- 3. The storage atmosphere must be free of gas containing sulfur and chlorine. Also, avoid exposing the product to saline moisture. If the product is exposed to such atmospheres, the terminals will oxidize and solderability will be effected.
- 4. Precautions 1) to 3) apply to chip capacitors packaged in carrier tapes and bulk cases.
- 5. The solderability is assured for 12 months from our shipping date (six months for silver palladium) if the above storage precautions are followed.
- 6. Chip capacitors may crack if exposed to hydrogen (H2) gas while sealed or if coated with silicon, which generates hydrogen gas.

Safety application guideline and detailed information of electrical properties are also provided in Kyocera home page; URL: http://www.kyocera.co.jp/electronic/